

XNF6N60T

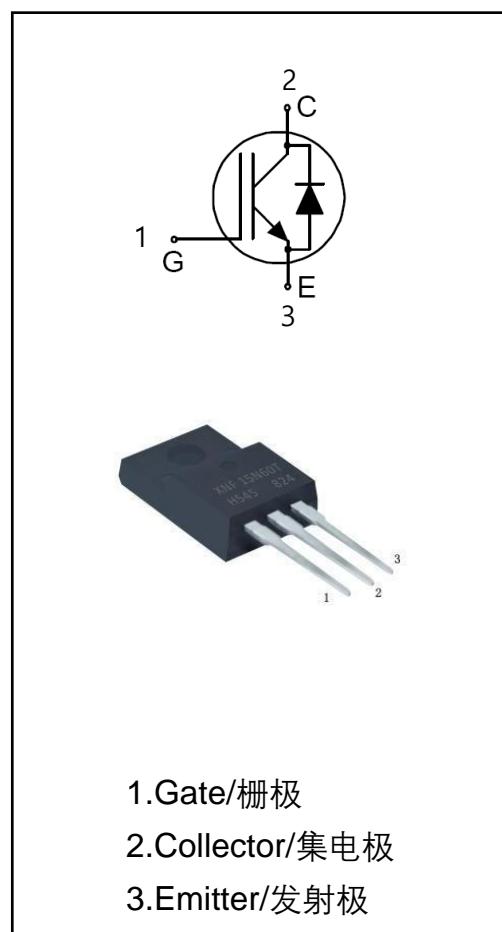
600V/6A 沟槽栅场截止型 IGBT

■ 产品特点/PRODUCT FEATURES

- 先进的沟槽栅+场截止技术
Advanced Trench+FS IGBT technology
- 超低饱和压降
Low Collector-Emitter Saturation voltage
- 反并快恢复二极管
With anti-parallel fast recovery diode
- 最高结温 $T_J = 175^\circ\text{C}$
Maximum junction temperature: $T_J = 175^\circ\text{C}$

■ 应用领域/APPLICATIONS

- 电机控制器
Motor control



关键性能和封装信息/Key Performance and Package Parameters

| Type | V_{CE} | I_C | $V_{CEsat}, T_{vj}=25^\circ\text{C}$ | T_{vjmax} | Package |
|----------|----------|-------|--------------------------------------|-------------|---------|
| XNF6N60T | 600V | 6A | 2V | 175°C | TO-220F |

深圳芯能半导体技术有限公司
Shenzhen invsemi technology co.,ltd

[IGBT_IPM_PIM_HVIC_深圳芯能半导体技术有限公司 \(invsemi.com\)](http://invsemi.com)

额定值、热阻 Ratings & Thermal Resistance

最大额定值/ Maximum Ratings

| 符号/Symbol | 参数/Parameter | 条件/Condition | 值/Value | 单位/Unit |
|---------------|---|---|------------|--------------------|
| V_{CES} | 集电极-发射极电压 Collector-to-emitter voltage | $T_{vj}=25^{\circ}\text{C}$ | 600 | V |
| I_C | 集电极连续直流电流 DC Collector current | $T_C = 25^{\circ}\text{C}$ | 12 | A |
| | | $T_C = 100^{\circ}\text{C}$ | 6 | |
| $I_{CRM}^{①}$ | 集电极可重复脉冲电流 Pulsed Collector current | $T_{vj} \leq 175^{\circ}\text{C}$ | 18 | A |
| I_F | 二极管连续直流电流 Diode continuous forward current | $T_C = 25^{\circ}\text{C}$ | 12 | A |
| | | $T_C = 100^{\circ}\text{C}$ | 6 | |
| $I_{FRM}^{①}$ | 二极管可重复脉冲电流 Diode pulsed current | $T_{vj} \leq 175^{\circ}\text{C}$ | 18 | A |
| V_{GES} | 栅极-发射极峰值电压 Gate to emitter voltage | $T_{vj}=25^{\circ}\text{C}$ | ± 30 | V |
| t_{sc} | 短路耐量 Short circuit withstand time | $V_{GE}=15\text{V}, V_{CC} \leq 400\text{V}$ $T_{vj}=25^{\circ}\text{C}$ | 5 | μs |
| P_{tot} | 总耗散功率 Power dissipation | $T_C = 25^{\circ}\text{C}$ | 30 | W |
| T_{vj} | 可工作结温 Operating Junction Temperature | — | -40~+ 175 | $^{\circ}\text{C}$ |
| T_{stg} | 储存温度 Storage Temperature Range | — | -50~ + 150 | $^{\circ}\text{C}$ |

① 脉宽受限于最高结温/Pulse width limited by T_{vjmax}

热阻/Thermal Resistance

| 符号/Symbol | 参数/Parameter | 最大值/Max.Value | 单位/Unit |
|----------------|---|---------------|---------|
| $R_{th(J-C)}$ | IGBT 芯片到底板热阻 IGBT thermal resistance Junction-to-Case | 5 | K/W |
| $R_{th-(J-C)}$ | 二极管芯片到底板热阻 FRD thermal resistance Maximum Junction-to-Case | 5.2 | K/W |
| $R_{th(J-A)}$ | 结到环境热阻 Thermal resistance Junction-to-Ambient | 80 | K/W |

电气特性

Electrical Characteristic

静态电气特性/Static Electrical Characteristic

| 符号 Symbol | 参数 Parameter | 测试条件 Test conditions | Value 值 | | | 单位 Units |
|---------------|--|---|---------|------|-----------|-------------|
| | | | Min | Typ | Max | |
| $V_{(BR)CES}$ | 集电极-发射极击穿电压 Collector - Emitter breakdown voltage | $V_{GE}=0V, I_C = 0.2mA, T_{vj}=25^\circ C$ | 600 | — | — | V |
| $V_{CE(sat)}$ | 集电极-发射极饱和压降 Collector-Emitter Saturation voltage | $V_{GE}=15V, I_C=6A, T_{vj}=25^\circ C$ | — | 2 | 2.4 | V |
| | | $V_{GE}=15V, I_C=6A, T_{vj}=175^\circ C$ | — | 2.3 | — | |
| $V_{GE(th)}$ | 门极开启阈值电压 Gate threshold voltage | $V_{GE}=V_{CE}, I_C=1mA, T_{vj}=25^\circ C$ | 4.8 | 5.75 | 6.3 | V |
| V_F | 二极管正向导通压降 Diode Forward Voltage | $V_{GE}=0V, I_F=6A, T_{vj}=25^\circ C$ | — | 1.4 | 1.9 | V |
| | | $V_{GE}=0V, I_F=6A, T_{vj}=175^\circ C$ | — | 1.2 | — | |
| I_{GES} | 门极-发射极漏电流 Gate to Emitter Leakage current | $V_{GE}=\pm 30V, V_{CE}=0V, T_{vj}=175^\circ C$ | — | — | ± 100 | nA |
| I_{CES} | 集电极-发射极漏电 Zero gate voltage collector current | $V_{CE}=600V, V_{GE}=0V, T_{vj}=175^\circ C$ | — | — | 300 | uA |
| R_{Gin} | 内部门极电阻 Integrated gate resistor | — | — | 0 | — | Ω |

动态电气特性/Dynamic Electrical Characteristic

| 符号 Symbol | 参数 Parameter | 测试条件 Test conditions | Value 值 | | | 单位 Units |
|--------------|--|--|---------|-----|-----|-------------|
| | | | Min | Typ | Max | |
| C_{ies} | 输入电容 Input capacitance | $V_{GE} = 0V, V_{CE} = 25V, f = 1MHz, T_{vj}=25^\circ C$ | — | 339 | — | pF |
| C_{oes} | 输出电容 Output capacitance | | — | 20 | — | |
| C_{res} | 反向传输电容 Reverse transfer capacitance | | — | 7.4 | — | |
| Q_g | 门极电量 Total gate charge | $I_C = 6A, V_{CE} = 480V, V_{GE} = 15V, T_{vj} = 25^\circ C$ | — | 19 | — | nC |
| Q_{ge} | 门极-发射极电量 Gate to emitter charge | | — | 3 | — | |
| Q_{gc} | 门极-集电极电量 Gate to collector charge | | — | 10 | — | |

开关特性、感性负载

Switching Characteristic Inductive Load

IGBT 特性/IGBT Characteristic

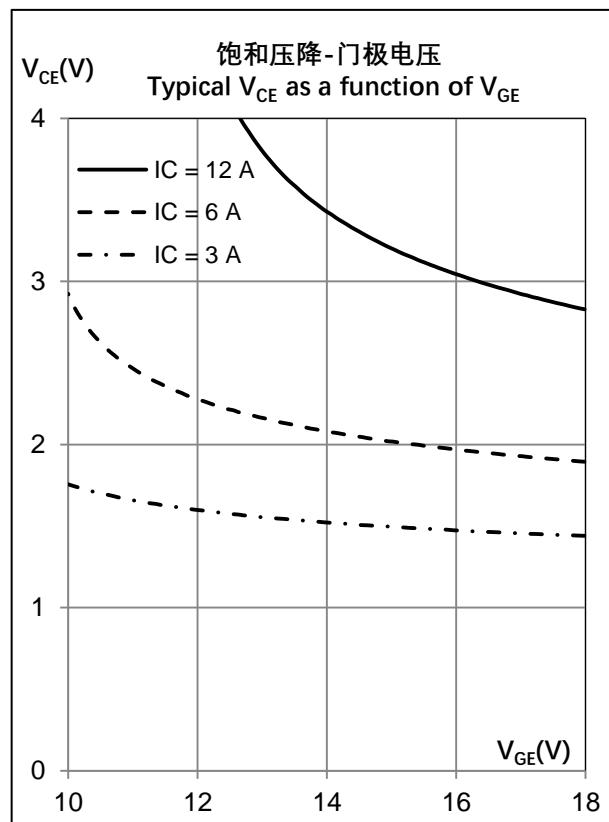
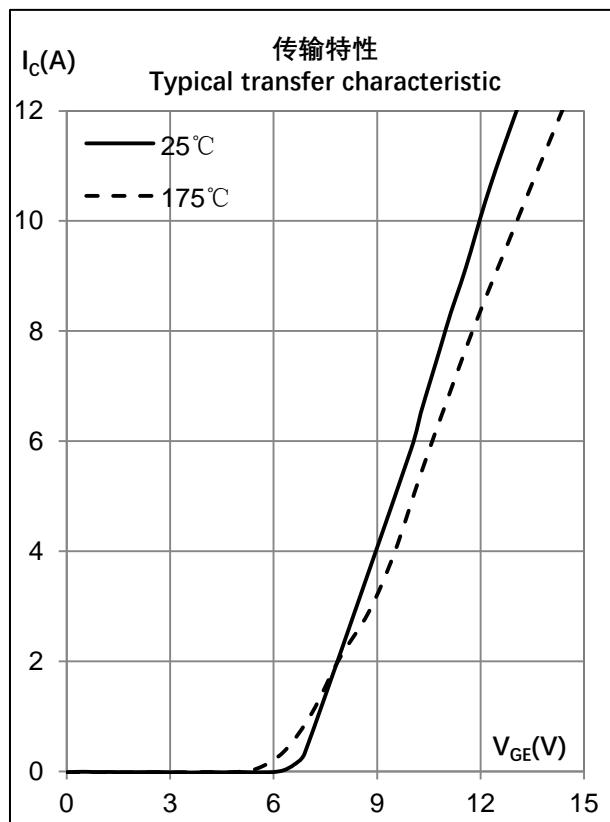
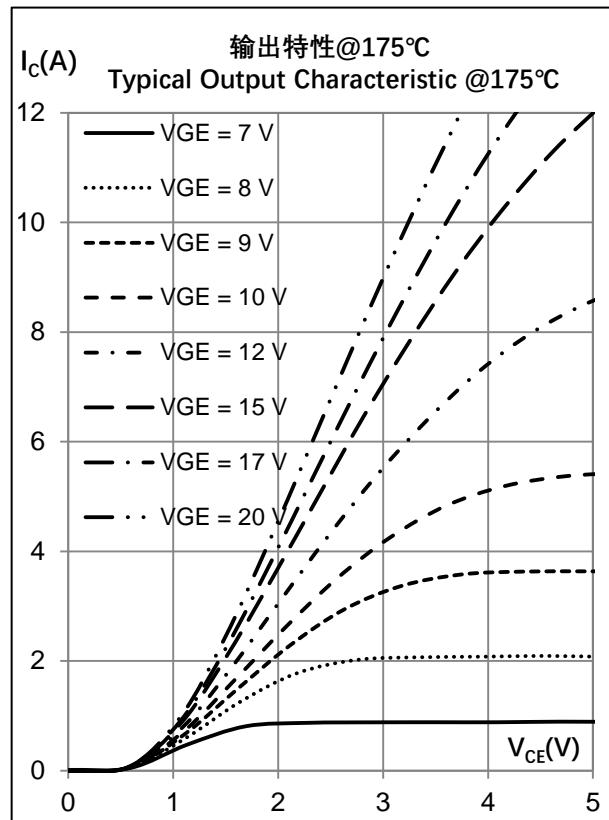
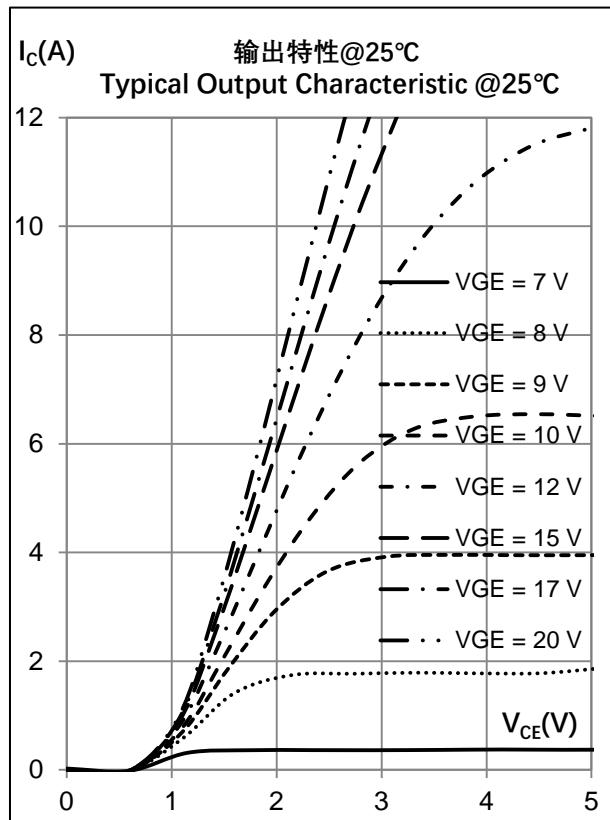
| 符号 Symbol | 参数 Parameter | 测试条件 Test conditions | 值 Value | | | 单位 Units | |
|---------------------|--------------------------------|--|------------------------|-----|-----|-------------|----|
| | | | Min | Typ | Max | | |
| T _{d(on)} | 开启延迟时间 Turn-On Delay Time | $V_{CC}=400V$ $I_C=6A$ $R_{G(on)}=20\Omega$ $R_{G(off)}=20\Omega$ $C=0nF$ $V_{GE}=15V$ $L_{load}=400\mu H$ | T _{vj} =25°C | — | 16 | — | ns |
| | | | T _{vj} =175°C | — | 17 | — | |
| Tr | 上升时间 Rise time | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 16 | — | ns |
| | | | T _{vj} =175°C | — | 20 | — | |
| T _{d(off)} | 关闭延迟时间 Turn-Off Delay Time | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 33 | — | ns |
| | | | T _{vj} =175°C | — | 34 | — | |
| t _f | 下降时间 Turn-Off Fall Time | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 89 | — | ns |
| | | | T _{vj} =175°C | — | 122 | — | |
| E _{on} | 单次开启损耗 Turn-on switch loss | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 107 | — | μJ |
| | | | T _{vj} =175°C | — | 241 | — | |
| E _{off} | 单次关闭损耗 Turn-off switch loss | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 105 | — | μJ |
| | | | T _{vj} =175°C | — | 133 | — | |

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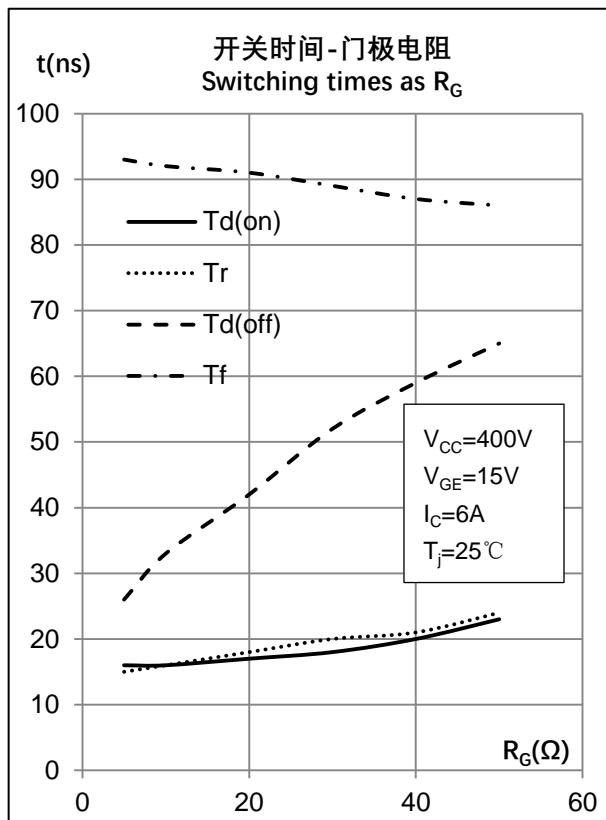
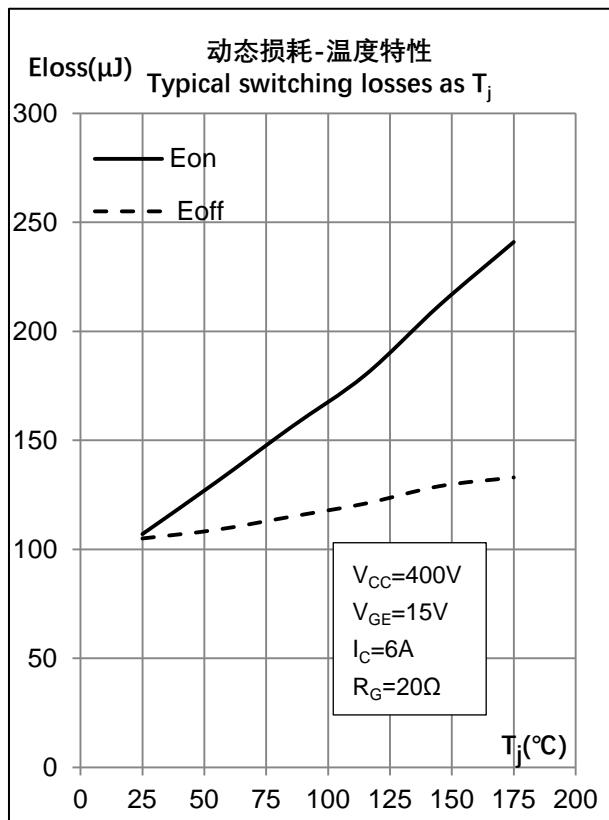
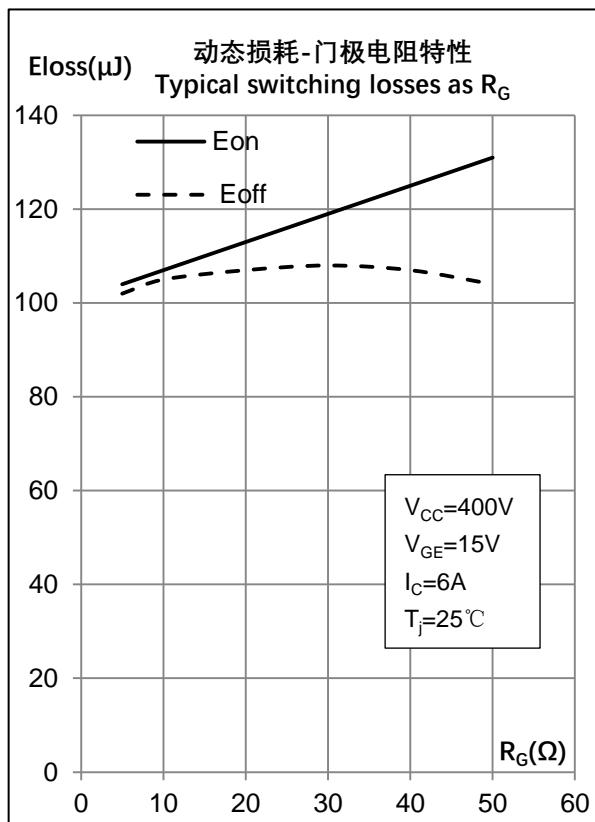
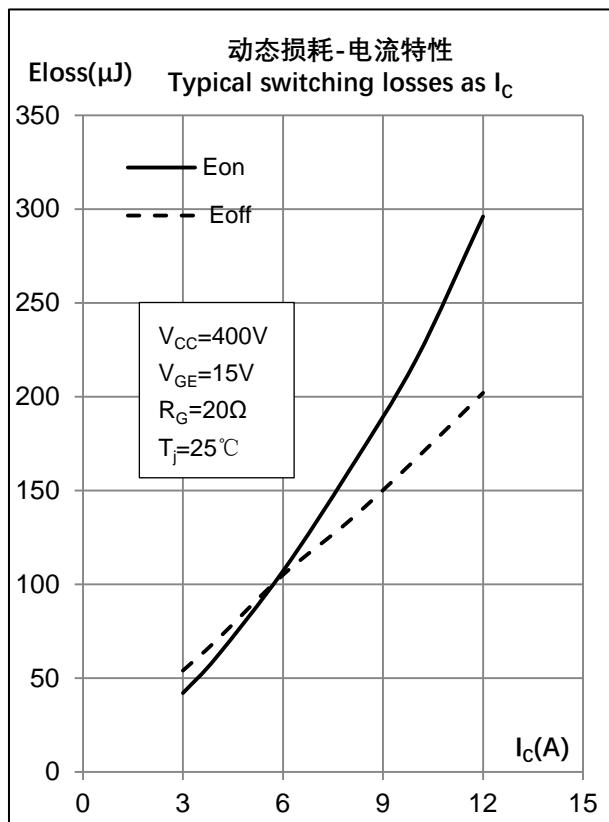
二极管特性/Diode Characteristic

| 符号 Symbol | 参数 Parameter | 测试条件 Test conditions | 值 Value | | | 单位 Units | |
|----------------------|---|---|------------------------|-----|-----|-------------|------|
| | | | Min | Typ | Max | | |
| t _{rr} | 二极管反向恢复时间 Diode Reverse Recovery Time | $I_F = 6A$ $V_R=400V$ $di_F/dt=-410A/\mu s$ | T _{vj} =25°C | — | 78 | — | ns |
| | | | T _{vj} =175°C | — | 232 | — | |
| Q _{rr} | 二极管反向恢复电量 Diode Reverse Recovery Charge | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 121 | — | nC |
| | | | T _{vj} =175°C | — | 468 | — | |
| I _{rrm} | 反向恢复峰值电流 Peak reverse recovery current | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 4.8 | — | A |
| | | | T _{vj} =175°C | — | 6.5 | — | |
| di _{rr} /dt | 恢复下降电流最大电流变化率 Peak rate of i _{rr} | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 127 | — | A/μs |
| | | | T _{vj} =175°C | — | 56 | — | |
| E _{rec} | 二极管反向恢复损耗 Diode Reverse Recovery loss | $T_vj=25^{\circ}C$ $T_vj=175^{\circ}C$ | T _{vj} =25°C | — | 19 | — | μJ |
| | | | T _{vj} =175°C | — | 92 | — | |

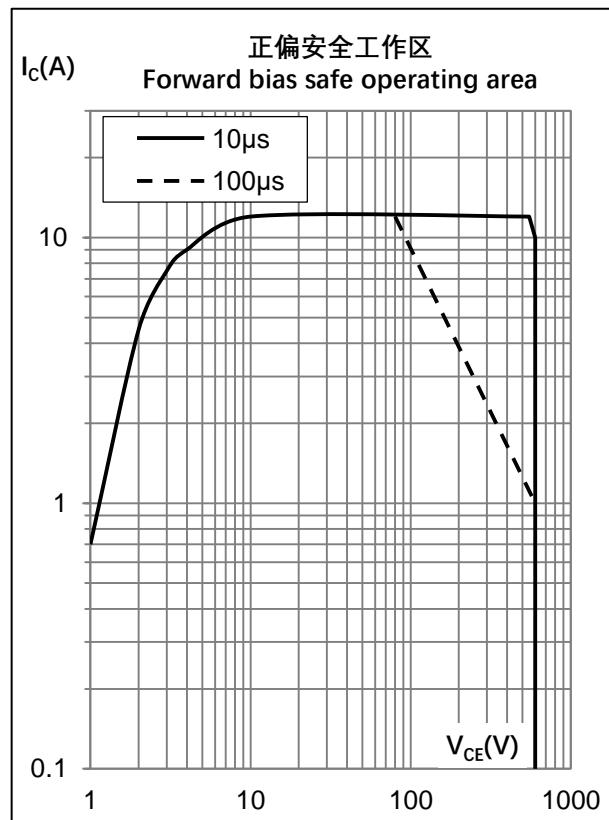
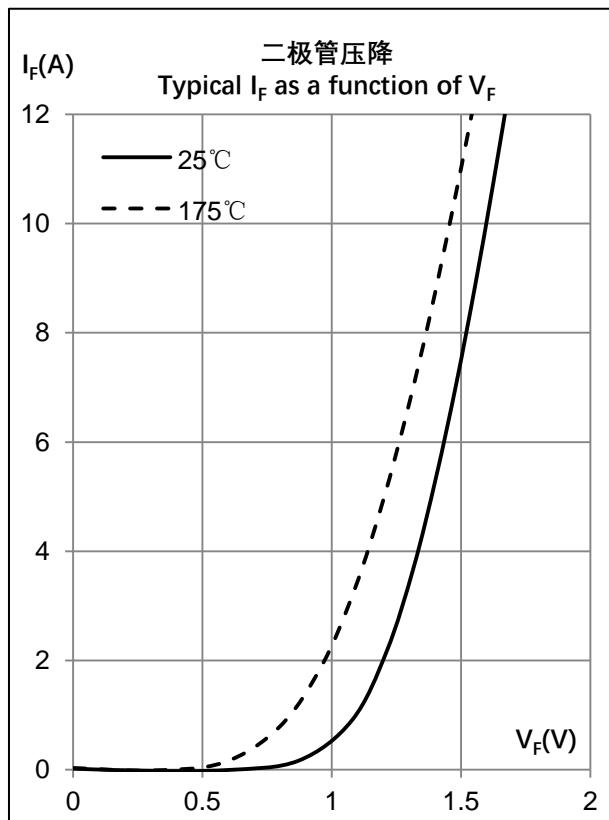
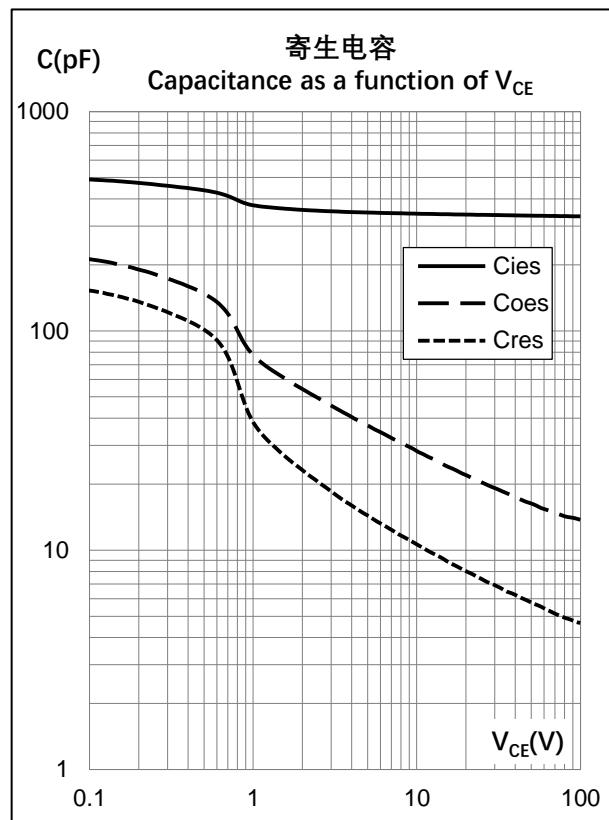
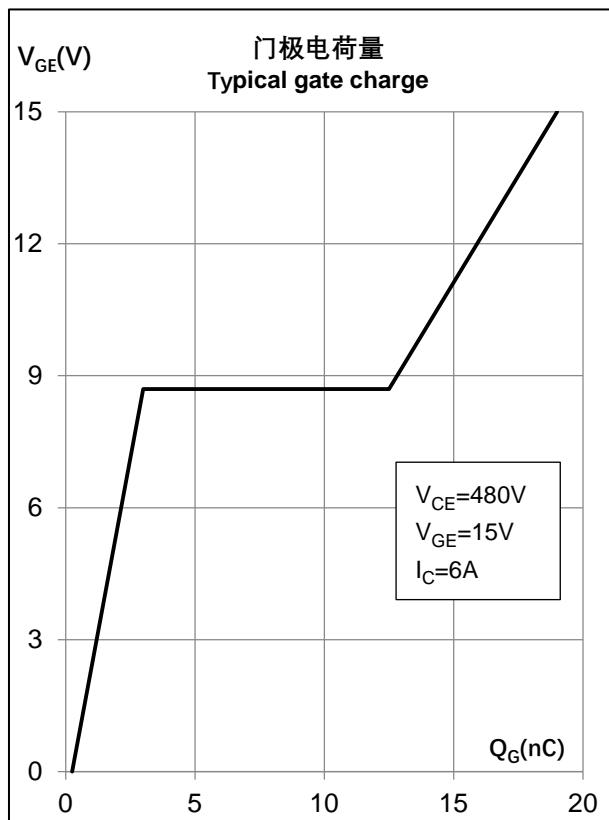
特征曲线
Characteristic Curve



特征曲线
Characteristic Curve

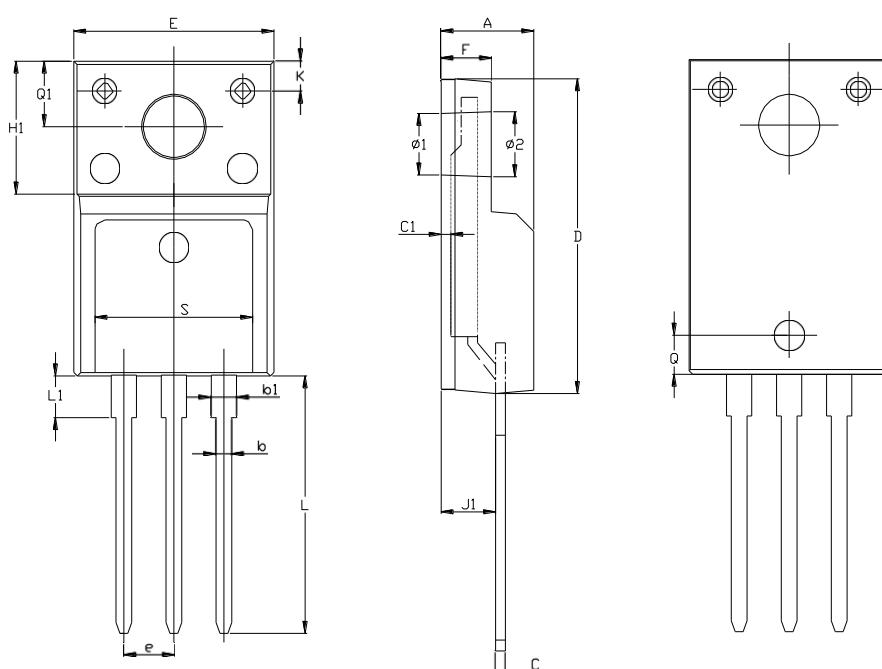


特征曲线
Characteristic Curve



TO-220F 封装数据

TO-220F Package Data



| DIM | MIM(mm) | MAX(mm) |
|--------|----------|---------|
| A | 4.53 | 4.93 |
| b | 0.71 | 0.91 |
| b1 | 1.15 | 1.39 |
| C / C1 | 0.45 | 0.6 |
| D | 15.67 | 16.07 |
| E | 9.96 | 10.36 |
| F | 2.34 | 2.74 |
| H1 | 6.5 | 6.9 |
| J | 0.32 | 0.43 |
| J1 | 2.56 | 2.96 |
| K | 1.9 | 2.1 |
| e | 2.54 BSC | |
| Q | 1.9 | 2.1 |
| Q1 | 3.1 | 3.5 |
| S | 7.9 | 8.1 |
| L | 12.78 | 13.18 |
| L1 | 1.9 | 2.3 |
| Ø1 | 3.08 | 3.28 |
| Ø2 | 3.35 | 3.55 |

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